

<b>Notice of References Cited</b>	Application/Control No. 09/398,126	Applicant(s)/Patent Under Reexamination SASAKI ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2005/0105030	05-2005	Kim et al.	349/129
	C	US-2004/0246422	12-2004	Seo et al.	349/129
	D	US-2004/0080697	04-2004	Song et al.	349/130
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	K	US-			
	L	US-			
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